	Course Information
Prerequisite	COM 3900 Mathematics for Machine Learning
Description	This course takes an application driven approach to current topics in machine learning. The course covers supervised learning, unsupervised learning, semi-supervised learning, and several other learning settings. We will cover popular algorithms and will focus on how statistical learning algorithms are applied to real world applications. Students will implement several learning algorithms throughout the semester. The goal of this course is to provide students with the basic tools they need to approach various applications, such as Biology/Bioinformatics, Information Retrieval, Natural Language Processing, Speech Processing, and Vision. We will focus on fundamental methods applicable to all applications.
Course	Students will learn the fundamentals of machine learning
Outcomes	Students will learn to implement machine learning algorithms
	Students will learn to evaluate how to apply machine learning to different settings
Major	Overview of Machine Learning (ML) applications
Topics	Linear Regression background
Covered in	 Supervised Learning (up to midterm exam)
Course	 Logistic Regression, introducing various classification methods
	 Perceptron and related online learning methods
	 Support Vector Machines: max-margin classification and optimization
	 Kernel Methods, especially dual optimization
	 Decision Trees: construction, pruning, and over-fitting
	 Boosting, especially ensemble methods
	 Deep Learning
	Unsupervised Learning (after midterm exam)
	 Clustering
	 Expectation Maximization techniques
	 Dimensionality Reduction and Principal Components Analysis
	 Graphical Methods Shanda and David Island
	• Structured Prediction
T. I. D 1 (.)	Practical Application of Machine Learning
Text Book(s)	Required : Kevin Murphy, <i>Machine Learning, a Probabilistic Perspective</i> , 1 st edition, MIT Press (2012) [author disavows the eBook version sold on Amazon, only buy an eBook from MIT Press] Supplemental :
	Christopher Bishop, Pattern Recognition and Machine Learning, Springer (2011 printing)
Assignments	Students will complete 4 major assignments applying established Machine Learning
	techniques in different problem domains and analyzing the resulting performance. These
	assignments will involve mathematical analysis, programming, and writing. Different
Accience	techniques and data sets will be selected each term.
Assignment	The assignments will be graded as follows:
Grading	Correctness and readability of program code: 40%
	Mathematical analysis of results: 40%
	Clarity and cogency of writing style: 20%
	Assignments submitted after the due date & time receive a grade of zero.

Exams	There will be a midterm exam in the 8 th week as well as a final exam.
Components	Assignments: 50%
of Student's	Final exam: 30%
Grade	Midterm exam: 20%
Grading	A = $93-100\%$ B+ = $87-89\%$ C+ = $77-79\%$ D+ = $67-69\%$
Scale:	A-=90-92% B = 83-86% C = 73-76% D = 65-66%
	B- = $80-82\%$ C- = $70-72\%$ F = 64 and lower
Credits	3
Weekly Schedule	Two sessions a week, 75 minutes each.
Attendance Policy	 Attendance of every session is mandatory. Every unexcused absence incurs a penalty of one point off the final exam. Every third unexcused absence additionally incurs the penalty of the student's final grade in the course being lowered by two letter "places" (e.g. from an A- to a B, from a B+ to a B-, etc.)
Y.C. C.S. Department Academic Integrity Policy	 If you need help with any aspect of any Y.C. C.S. course, please reach out to your professor and/or TA - we are there to help. Do not under any circumstances resort to cheating or plagiarizing in any way. All academic integrity cases in Y.C. C.S. classes will be handled as follows: 1) Every case will be referred to the dean's office for investigation and disciplinary measures - no exceptions 2) The first time a student is caught cheating or plagiarizing on any part of any work item (e.g. a homework assignment, exam, etc.) for any Y.C. C.S. course, he will receive a zero on the work item on which he cheated or plagiarized and have his final grade in the course lowered by an entire letter (e.g. from B+ to C+.) Repeat offenders, whether they repeat in a single semester or across multiple semesters, will be dealt with more stringently. These penalties have been, and will be, applied even if it means a senior not graduating and/or a student having to take the course all over again.
	For more information, please see Yeshiva College's Academic Integrity Policy.

Students With Disabilities

The Office of Academic Support provides services and resources designed to help students on Wilf Campus develop more efficient and effective study skills and strategies. Individual support is available in areas such as time management and organization, active reading, note-taking, exam preparation and test-taking skills. The office is located in Furst Hall, Suite 412. To schedule an appointment, call 646-592-4285 or email academicsupport.wilf@yu.edu.

Weekly Schedule	
Week	Topics
1	Overview of Machine Learning: history, relation to classical statistics Text: Chapter 1;

2	Linear Regression: model specification issues, maximum likelihood estimation, ridge
	regression
	Text: Chapter 7, except 7.4 and 7.6
3	Logistic Regression: model fitting methods (steepest descent, Newton's, L1 and L2
	regularization, etc.)
	Online learning algorithms: structured prediction, regret minimization, stochastic
	optimization, risk minimization, LMS algorithm, perceptron algorithm, relation to Bayesian
	techniques.
	Text: Chapter 8.1-8.3.6, 8.5, 13.3,
4	Support Vector Machines: uses in regression and classification, optimization, choice of
	parameter C, probabilistic interpretation
	Kernel Methods: RBF kernels, Mercer kernels, Matern kernels, Linear kernels, String kernels,
	Kernels derived from probabilistic generative models; the "kernel trick" and its uses: nearest
	neighbor classification, K-medoids clustering, ridge regression, and PCA
	Text: Chapter 14.1, 14.2, 14.5, supplemental notes by Ng
5	Decision Trees: basis in information theory, when appropriate to use, growing and pruning,
	detecting and avoiding over-fitting; pros and cons with respect to other ML techniques;
	random forests; ID3 and related algorithms; use of bias; training with incomplete data
	Boosting: why it works so well, specific types of boosting, ensemble learning
	Text: Chapters 2.8, 16.2, 16.4, 16.6, supplemental notes by Mitchell, Yoav & Schapire
6	Deep Learning: background in feed-forward neural networks (multilayer perceptrons) and
	Restricted Boltzmann machines; deep generative models (sigmoid networks, Boltzmann
	machines, belief networks)
	Text: Chapters 16.5, 27.7, 28.1-28.2
7	Deep Learning (continued): training of deep networks, applications of deep networks
	Midterm Review
	Text: Chapters 28.3-28.4
8	Midterm Exam
	Clustering: measures of dissimilarity; k-means clustering, clustering in mixture models
	Text: Chapters 25.1, 11.1-11.3
9	Expectation Maximization: basic idea, Jensen's inequality, the EM algorithm, EM applied to
	various distributions (mixture of Gaussians), theoretical basis
	Text: Chapters 11.4, supplemental notes by Ng
10	Dimensionality Reduction: classical Principal Components Analysis, PCA theorem; Singular
	Value Decomposition, Probabilistic PCA, EM algorithm for PCA, PCA for categorical data, PCA
	for paired and multi-view data
	Text: Chapters 12.2, 12.4, 12.5
11	Graphical Techniques: Bayesian nets, Directed Gaussian Models (DGM), plate notation, d-
	separation, Markov random fields, Hammersley-Clifford theorem and its effects, training
	maxent models, pseudo-likelihood, stochastic maximum likelihood learning
	Text: Chapter 10, 19.1-19.5

12	 Graphical Techniques (continued): belief propagation (serial, parallel, Gaussian, and other variants), variable elimination, junction trees, intractability of exact inference, approximate inference methods, max sum and max product Text: Chapter 20
13	 Structured Prediction: Markov and Hidden Markov (HMM) models, inference algorithms (forward, Viterbi, backward filtering, etc.), training methods, Baum-Welch algorithm, model selection, Conditional Random Fields (CRF), label-bias problem, uses in handwriting recognition, protein analysis, and stereopsis Text: Chapters 17.1-17.5, 19.6-19.7, CRF tutorial paper by Sutton & McCallum